


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,422	CHIEN, HUI-JAN	
	Examiner	Art Unit	
	YOSEF KASSA	2624	

SEARCHED			
Class	Subclass	Date	Examiner
382	167	2/20/2007	YK
382	260	2/20/2007	YK
382	274	2/20/2007	YK
382	275	2/20/2007	YK
358	3.26	2/20/2007	YK
358	3.27	2/20/2007	YK
358	518	2/20/2007	YK
358	520	2/20/2007	YK
358	463	2/20/2007	YK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PAT, PG-PUB), IEEE and inventor name searched	2/20/2007	YK